

**Search Notes**

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Examiner

Young J. Kim

Applicant(s)/Patent under  
Reexamination

EICHEN ET AL.

Art Unit

1637

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated	9/15/2007	YJK